# MOSFET – Power, Single, N-Channel 60 V, 64 mΩ, 17 A

## NVD5490NL

#### **Features**

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- High Current Capability
- Avalanche Energy Specified
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

#### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			$V_{DSS}$	60	V
Gate-to-Source Voltage			V <sub>GS</sub>	±20	V
Continuous Drain Cur-		T <sub>C</sub> = 25°C	I <sub>D</sub>	17	Α
rent R <sub>θJC</sub> (Notes 1 & 3)	Steady	T <sub>C</sub> = 100°C		12	
Power Dissipation R <sub>θJC</sub>	State	T <sub>C</sub> = 25°C	$P_{D}$	49	W
(Note 1)		T <sub>C</sub> = 100°C		24	
Continuous Drain Cur-		T <sub>A</sub> = 25°C	I <sub>D</sub>	5.0	Α
rent $R_{\theta JA}$ (Notes 1, 2 & 3)	Steady	T <sub>A</sub> = 100°C		3.0	
Power Dissipation R <sub>θJA</sub>	State	T <sub>A</sub> = 25°C	$P_{D}$	3.4	W
(Notes 1 & 2)			T <sub>A</sub> = 100°C		1.7
Pulsed Drain Current	$T_A = 25^{\circ}C, t_p = 10 \mu s$		I <sub>DM</sub>	71	Α
Current Limited by Package (Note 3)	T <sub>A</sub> = 25°C		I <sub>Dmaxpkg</sub>	30	Α
Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>stg</sub>	-55 to 175	°C
Source Current (Body Diode)			IS	41	Α
Single Pulse Drain-to-Source Avalanche Energy (T <sub>J</sub> = 25°C, V <sub>DD</sub> = 30 V, V <sub>GS</sub> = 10 V, $I_{L(pk)}$ = 9.0 A, L = 1.0 mH, $R_G$ = 25 $\Omega$ )			E <sub>AS</sub>	41	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			T <sub>L</sub>	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

#### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Drain)	$R_{\theta JC}$	3.1	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	44	

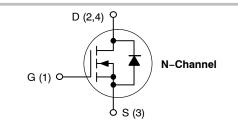
- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 650 mm<sup>2</sup>, 2 oz. Cu pad.
- 3. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.



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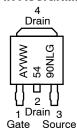
V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub>	I <sub>D</sub>
60 V	64 mΩ @ 10 V	17 A
	85 mΩ @ 4.5 V	17.7





DPAK CASE 369AA STYLE 2

## MARKING DIAGRAMS & PIN ASSIGNMENT



A = Assembly Location\*

Y = Year WW = Work Week 5490L = Device Code G = Pb-Free Package

\* The Assembly Location code (A) is front side optional. In cases where the Assembly Location is stamped in the package, the front side assembly code may be blank.

#### **ORDERING INFORMATION**

See detailed ordering and shipping information in the package dimensions section on page 5 of this data sheet.

### **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D =$	= 250 μA	60			V
Zero Gate Voltage Drain Current	ain Current $I_{DSS}$ $V_{GS} = 0 \text{ V},$ $T_J = 25^\circ$		T <sub>J</sub> = 25°C			1.0	μΑ
		$V_{DS} = 60 \text{ V}$ $T_{J} = 125^{\circ}\text{C}$			10		
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub>	= ±20 V			±100	nA
ON CHARACTERISTICS (Note 4)					-		
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D$	= 250 μΑ	1.5		2.5	V
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I	<sub>D</sub> = 9 A		46	64	mΩ
		$V_{GS} = 4.5 \text{ V},$	<sub>D</sub> = 9 A		66	85	
Forward Transconductance	9FS	V <sub>DS</sub> = 15 V, I <sub>E</sub>	<sub>)</sub> = 20 A		15		S
CHARGES, CAPACITANCES & GATE I	RESISTANCE				•	•	
Input Capacitance	C <sub>iss</sub>				365		pF
Output Capacitance	C <sub>oss</sub>	$V_{GS} = 0 \text{ V, f} = V_{DS} = 25$	1.0 MHz, 5 V		91		1
Reverse Transfer Capacitance	C <sub>rss</sub>	*DS - 20	, ,		46		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>DS</sub> = 48 V,	V <sub>GS</sub> = 4.5 V		7.8		nC
		$I_D = 9 A$	V <sub>GS</sub> = 10 V		14		
Threshold Gate Charge	Q <sub>G(TH)</sub>	V <sub>DS</sub> = 48 V, I <sub>D</sub> = 9 A V <sub>GS</sub> = 10 V			0.4		nC
Gate-to-Source Charge	Q <sub>GS</sub>				1.5		nC
Gate-to-Drain Charge	$Q_{GD}$				5.4		nC
Gate Resistance	$R_{G}$				7		Ω
SWITCHING CHARACTERISTICS (No	te 5)						
Turn-On Delay Time	t <sub>d(on)</sub>				9.4		ns
Rise Time	t <sub>r</sub>	$V_{DS} = 48 \text{ V}, V_{G}$	s = 4.5 V,		57		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D = 9 A, R_G$	= 10 Ω		24		
Fall Time	t <sub>f</sub>				35		
Turn-On Delay Time	t <sub>d(on)</sub>				6.7		ns
Rise Time	t <sub>r</sub>	V <sub>DS</sub> = 48 V, V <sub>G</sub>	<sub>.S</sub> = 10 V,		17		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D = 9 A, R_G$	= 10 Ω		34		1
Fall Time	t <sub>f</sub>	1			34		1
DRAIN-SOURCE DIODE CHARACTER	RISTICS						
Forward Diode Voltage	$V_{SD}$	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 9 A	T <sub>J</sub> = 25°C		0.97	1.2	V
			T <sub>J</sub> = 125°C		0.87		1
Reverse Recovery Time	t <sub>rr</sub>				25		ns
Charge Time	t <sub>a</sub>	$I_{S} = 20.5 A_{dc}, V_{GS} = 0 V_{dc},$ $dI_{S}/dt = 100 A/\mu s$			20		1
Discharge Time	t <sub>b</sub>				5.0		1
Reverse Recovery Stored Charge	Q <sub>RR</sub>				27		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

#### **TYPICAL CHARACTERISTICS**

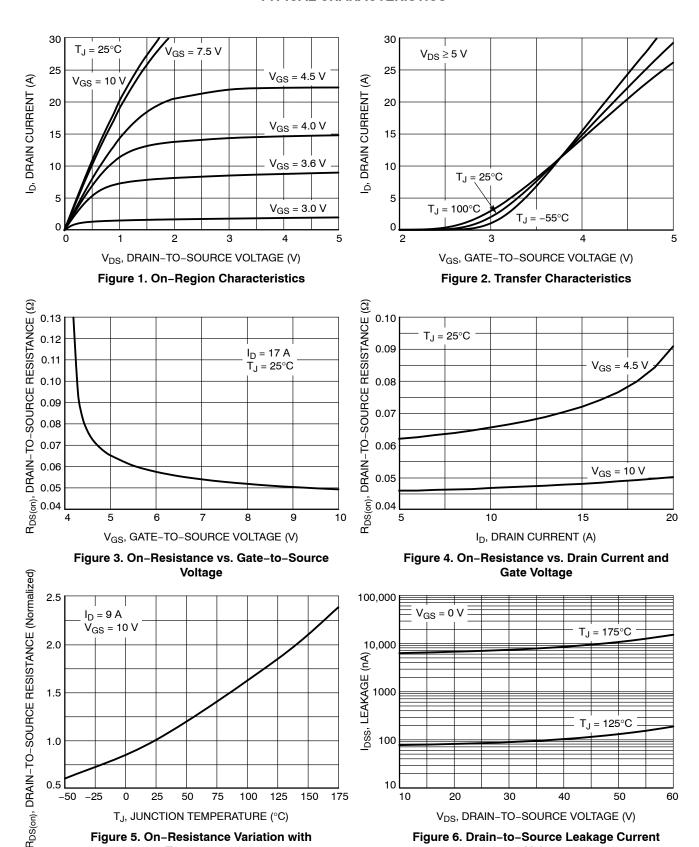


Figure 6. Drain-to-Source Leakage Current

vs. Voltage

Figure 5. On-Resistance Variation with

**Temperature** 

#### **TYPICAL CHARACTERISTICS**

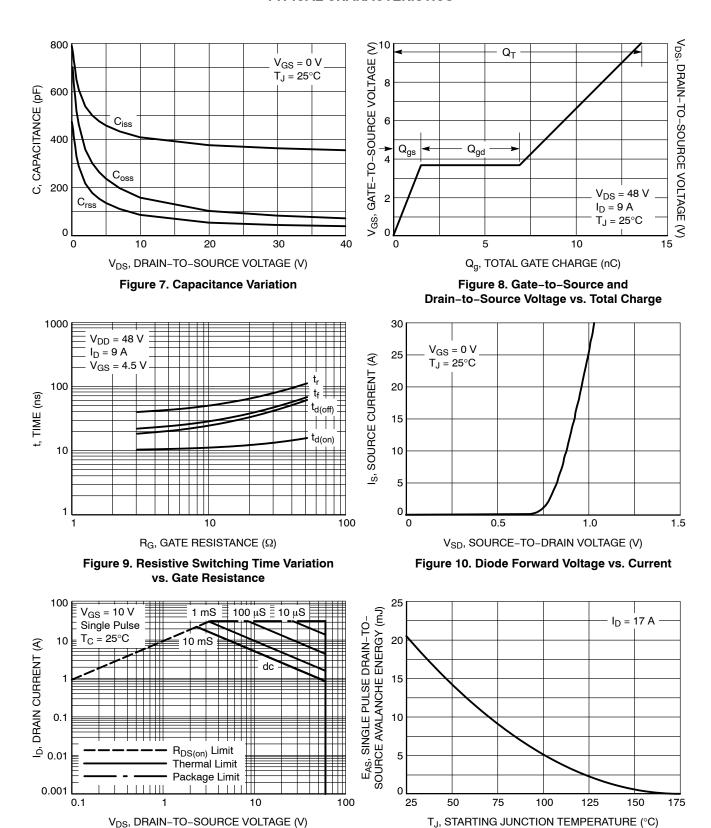


Figure 11. Maximum Rated Forward Biased Safe Operating Area

Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

#### **TYPICAL CHARACTERISTICS**

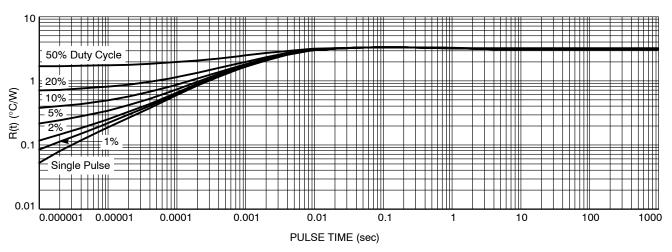
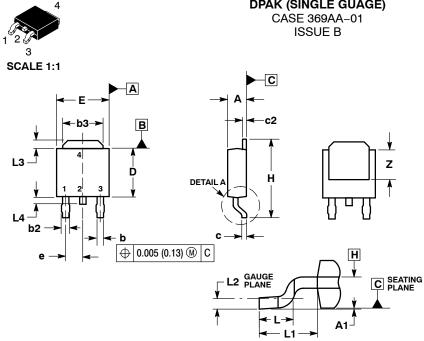


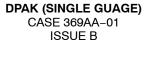
Figure 13. Thermal Response

#### **ORDERING INFORMATION**

Order Number	Package	Shipping <sup>†</sup>
NVD5490NLT4G	DPAK (Pb-Free)	2500 / Tape & Reel
NVD5490NLT4G-VF01	DPAK (Pb-Free)	2500 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.





**DETAIL A** ROTATED 90° CW **DATE 03 JUN 2010** 

#### NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- 2. CONTROLLING DIMENSION: INCHES.
  3. THERMAL PAD CONTOUR OPTIONAL WITHIN DI-MENSIONS b3, L3 and Z.
  4. DIMENSIONS D AND E DO NOT INCLUDE MOLD
- FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE
- DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 6. DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.

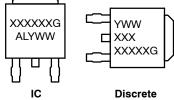
	INC	HES	MILLIN	IETERS	
DIM	MIN	MAX	MIN	MAX	
Α	0.086	0.094	2.18	2.38	
A1	0.000	0.005	0.00	0.13	
b	0.025	0.035	0.63	0.89	
b2	0.030	0.045	0.76	1.14	
b3	0.180	0.215	4.57	5.46	
С	0.018	0.024	0.46	0.61	
c2	0.018	0.024	0.46	0.61	
D	0.235	0.245	5.97	6.22	
E	0.250	0.265	6.35	6.73	
е	0.090	BSC	2.29 BSC		
Н	0.370	0.410	9.40	10.41	
L	0.055	0.070	1.40	1.78	
L1	0.108 REF		2.74 REF		
L2	0.020 BSC		0.51 BSC		
L3	0.035	0.050	0.89	1.27	
L4		0.040		1.01	
Z	0.155		3.93		

**GENERIC** 

MARKING DIAGRAM\*

#### STYLE 4: PIN 1. CATHODE 2. ANODE 3. GATE STYLE 1: PIN 1. BASE STYLE 2: PIN 1. GATE STYLE 3: PIN 1. ANODE 2. COLLECTOR 3. EMITTER 2. CATHODE 3. ANODE 2. DRAIN 3. SOURCE 4. COLLECTOR 4. DRAIN CATHODE STYLE 5: STYLE 6: STYLE 7: PIN 1. GATE 2. ANODE 3. CATHODE PIN 1. GATE 2. COLLECTOR PIN 1. MT1 2. MT2 3. GATE 3. EMITTER 4. ANODE COLLECTOR

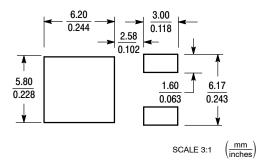
#### XXXXXXG



XXXXXX = Device Code Α = Assembly Location L = Wafer Lot ٧ = Year = Work Week WW = Pb-Free Package

\*This information is generic. Please refer to device data sheet for actual part marking.

#### **SOLDERING FOOTPRINT\***



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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